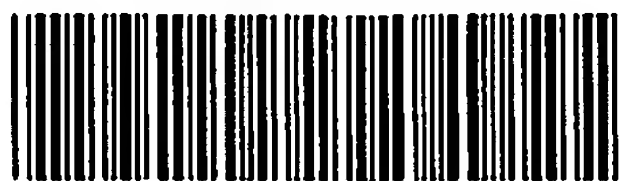


Search Notes



Application/Control No.

10/518,367

Examiner

Tran N. Nguyen

Applicant(s)/Patent under Reexamination

SHIGA ET AL.

Art Unit

2834

SEARCHED

Class	Subclass	Date	Examiner
310	43	4/24/05	TNN
	216		
	217		
	156.08		
	156.15		
	156.28		
	156.29		
	156.53		
	156.56		
	156.38		
	156.39		
update	9/13/06	TNN	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
310	all above	9/13/06	TNN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Interference Search	9/13/06	TNN